Unit in mm

TOSHIBA TRANSISTOR SILICON PNP EPITAXIAL TYPE (PCT PROCESS)

2 S A 1 4 2 5

POWER AMPLIFIER APPLICATIONS

DRIVER STAGE AMPLIFIER APPLICATIONS

• Complementary to 2SC3665.

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC	SYMBOL	RATING	UNIT	
Collector-Base Voltage	v_{CBO}	-120	V	
Collector-Emitter Voltage	v_{CEO}	-120	V	
Emitter-Base Voltage	$V_{ m EBO}$	- 5	V	
Collector Current	$I_{\mathbf{C}}$	-800	mA	
Base Current	$I_{\mathbf{B}}$	-80	mA	
Collector Power Dissipation	$P_{\mathbf{C}}$	1000	mW	
Junction Temperature	T_{j}	150	°C	
Storage Temperature Range	$\mathrm{T_{stg}}$	-55~150	°C	

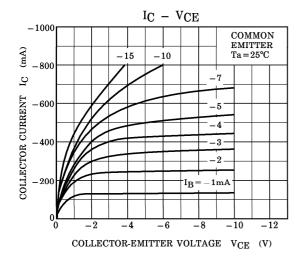
Weight: 0.2g (Typ.)

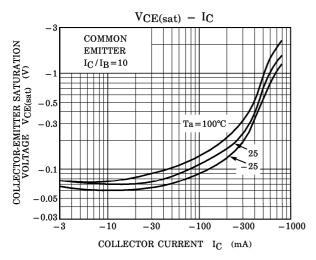
ELECTRICAL CHARACTERISTICS (Ta = 25°C)

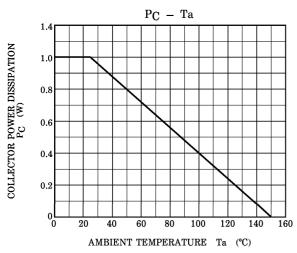
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	I_{CBO}	$V_{CB} = -120V, I_E = 0$	_	_	-100	nA
Emitter Cut-off Current	I_{EBO}	$V_{EB} = -5V, I_C = 0$	_	_	-100	nA
Collector-Emitter Breakdown Voltage	V _{(BR)CEO}	$I_{C} = -10 \text{mA}, I_{B} = 0$	-120	_	_	V
Emitter-Base Breakdown Voltage	V _{(BR)EBO}	$I_E = -1$ mA, $I_C = 0$	-5	_	_	V
DC Current Gain	hFE (Note)	$V_{CE} = -5V, I_{C} = -100 \text{mA}$	80	_	240	
Collector-Emitter Saturation Voltage	V _{CE(sat)}	$I_{C} = -500 \text{mA}, I_{B} = -50 \text{mA}$	_	_	-1.0	V
Base-Emitter Voltage	$v_{ m BE}$	$V_{CE} = -5V, I_{C} = -500 \text{mA}$	_	_	-1.0	V
Transition Frequency	$ m f_{ m T}$	$V_{CE} = -5V, I_{C} = -100 \text{mA}$	_	120		MHz
Collector Output Capacitance	C _{ob}	$V_{CB} = -10V, I_E = 0, f = 1MHz$	_	_	40	pF

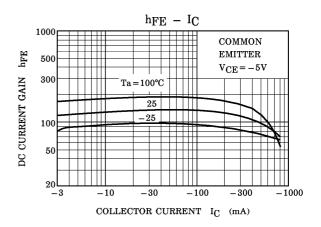
(Note): hFE Classification O: 80~160, Y: 120~240

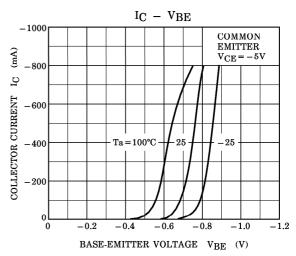
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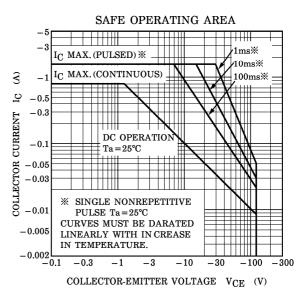












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